Search Notes

Application/Control N	o. Applicant(s)/Patent under Reexamination			
10/607,086	KAKU ET AL.			
Examiner	Art Unit			
Luan V Van	1753			

SEARCHED					
Class	Subclass	Date	Examiner		
205	50	6/27/05	LV		
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INTERFERENCE SEARCHED					
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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